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Accreditation No.: **SCS 108**

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Client **UL CCS USA**

Certificate No: **EX3-3531\_Dec11**

## CALIBRATION CERTIFICATE

Object

**EX3DV3 - SN:3531**

Calibration procedure(s)

**QA CAL-01.v8, QA CAL-12.v7, QA CAL-14.v3, QA CAL-23.v4,  
 QA CAL-25.v4  
 Calibration procedure for dosimetric E-field probes**

Calibration date:

**December 19, 2011**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature  $(22 \pm 3)^{\circ}\text{C}$  and humidity  $< 70\%$ .

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards          | ID              | Cal Date (Certificate No.)        | Scheduled Calibration  |
|----------------------------|-----------------|-----------------------------------|------------------------|
| Power meter E4419B         | GB41293874      | 31-Mar-11 (No. 217-01372)         | Apr-12                 |
| Power sensor E4412A        | MY41498087      | 31-Mar-11 (No. 217-01372)         | Apr-12                 |
| Reference 3 dB Attenuator  | SN: S5054 (3c)  | 29-Mar-11 (No. 217-01369)         | Apr-12                 |
| Reference 20 dB Attenuator | SN: S5086 (20b) | 29-Mar-11 (No. 217-01367)         | Apr-12                 |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 29-Mar-11 (No. 217-01370)         | Apr-12                 |
| Reference Probe ES3DV2     | SN: 3013        | 29-Dec-10 (No. ES3-3013_Dec10)    | Dec-11                 |
| DAE4                       | SN: 654         | 3-May-11 (No. DAE4-654_May11)     | May-12                 |
| Secondary Standards        | ID              | Check Date (in house)             | Scheduled Check        |
| RF generator HP 8648C      | US3642U01700    | 4-Aug-99 (in house check Apr-11)  | In house check: Apr-13 |
| Network Analyzer HP 8753E  | US37390585      | 18-Oct-01 (in house check Oct-11) | In house check: Oct-12 |

|                                                                                                                 | Name          | Function          | Signature                 |
|-----------------------------------------------------------------------------------------------------------------|---------------|-------------------|---------------------------|
| Calibrated by:                                                                                                  | Katja Pokovic | Technical Manager |                           |
| Approved by:                                                                                                    | Niels Kuster  | Quality Manager   |                           |
|                                                                                                                 |               |                   | Issued: December 19, 2011 |
| This calibration certificate shall not be reproduced except in full without written approval of the laboratory. |               |                   |                           |



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### Glossary:

|                          |                                                                                                                                                         |
|--------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------|
| TSL                      | tissue simulating liquid                                                                                                                                |
| NORM <sub>x,y,z</sub>    | sensitivity in free space                                                                                                                               |
| ConvF                    | sensitivity in TSL / NORM <sub>x,y,z</sub>                                                                                                              |
| DCP                      | diode compression point                                                                                                                                 |
| CF                       | crest factor (1/duty_cycle) of the RF signal                                                                                                            |
| A, B, C                  | modulation dependent linearization parameters                                                                                                           |
| Polarization $\phi$      | $\phi$ rotation around probe axis                                                                                                                       |
| Polarization $\vartheta$ | $\vartheta$ rotation around an axis that is in the plane normal to probe axis (at measurement center),<br>i.e., $\vartheta = 0$ is normal to probe axis |

### Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

### Methods Applied and Interpretation of Parameters:

- NORM<sub>x,y,z</sub>:** Assessed for E-field polarization  $\vartheta = 0$  ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide). NORM<sub>x,y,z</sub> are only intermediate values, i.e., the uncertainties of NORM<sub>x,y,z</sub> does not affect the  $E^2$ -field uncertainty inside TSL (see below ConvF).
- NORM(f)<sub>x,y,z</sub> = NORM<sub>x,y,z</sub> \* frequency\_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP<sub>x,y,z</sub>:** DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR:** PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A<sub>x,y,z</sub>; B<sub>x,y,z</sub>; C<sub>x,y,z</sub>; VR<sub>x,y,z</sub>:** A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters:** Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \leq 800$  MHz) and inside waveguide using analytical field distributions based on power measurements for  $f > 800$  MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM<sub>x,y,z</sub> \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from  $\pm 50$  MHz to  $\pm 100$  MHz.
- Spherical isotropy (3D deviation from isotropy):** in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset:** The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

# Probe EX3DV3

## SN:3531

Manufactured: May 17, 2004  
Calibrated: December 19, 2011

Calibrated for DASY/EASY Systems  
(Note: non-compatible with DASY2 system!)

